

Three quadrant triacs guaranteed commutation

BTA212X series D, E and F

GENERAL DESCRIPTION

Passivated guaranteed commutation triacs in a full pack, plastic envelope intended for use in motor control circuits or with other highly inductive loads. These devices balance the requirements of commutation performance and gate sensitivity. The "sensitive gate" E series and "logic level" D series are intended for interfacing with low power drivers, including micro controllers.

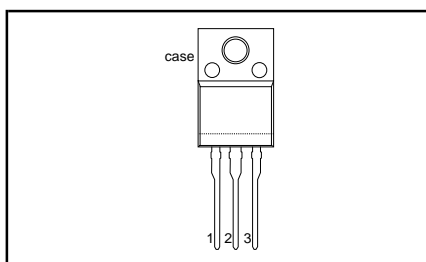
QUICK REFERENCE DATA

| SYMBOL | PARAMETER | MAX. | MAX. | UNIT |
|--------------|--------------------------------------|--|-----------------------|------|
| V_{DRM} | Repetitive peak off-state voltages | 600D 600E 600F 600 | - 800E - | V |
| $I_{T(RMS)}$ | RMS on-state current | 12 | 12 | A |
| I_{TSM} | Non-repetitive peak on-state current | 95 | 95 | A |

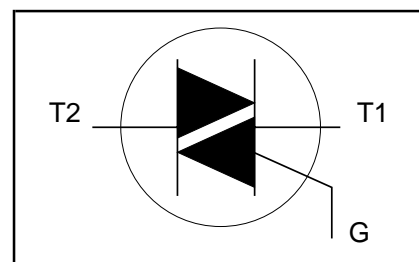
PINNING - SOT186A

| PIN | DESCRIPTION |
|------|-----------------|
| 1 | main terminal 1 |
| 2 | main terminal 2 |
| 3 | gate |
| case | isolated |

PIN CONFIGURATION



SYMBOL



LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | | UNIT |
|--------------|--|--|------|--------------------------|-------------|------------------|
| | | | | -600 600 ¹ | -800 800 | |
| V_{DRM} | Repetitive peak off-state voltages | | - | -600 600 ¹ | -800 800 | V |
| $I_{T(RMS)}$ | RMS on-state current | full sine wave; $T_{hs} \leq 56^\circ\text{C}$ | - | 12 | | A |
| I_{TSM} | Non-repetitive peak on-state current | full sine wave; $T_j = 25^\circ\text{C}$ prior to surge $t = 20\text{ ms}$ | - | 95 | | A |
| I^2t | I^2t for fusing | $t = 16.7\text{ ms}$ | - | 105 | | A |
| di_T/dt | Repetitive rate of rise of on-state current after triggering | $t = 10\text{ ms}$ $I_{TM} = 20\text{ A}; I_G = 0.2\text{ A}; di_G/dt = 0.2\text{ A}/\mu\text{s}$ | - | 45 | | A ² s |
| I_{GM} | Peak gate current | | - | 2 | | A |
| P_{GM} | Peak gate power | | - | 5 | | W |
| $P_{G(AV)}$ | Average gate power | over any 20 ms period | - | 0.5 | | W |
| T_{stg} | Storage temperature | | -40 | 150 | | $^\circ\text{C}$ |
| T_j | Operating junction temperature | | - | 125 | | $^\circ\text{C}$ |

¹ Although not recommended, off-state voltages up to 800V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 15 A/ μs .

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ISOLATION LIMITING VALUE & CHARACTERISTIC

$T_{hs} = 25\text{ °C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|------------|--|--|------|------|------|------|
| V_{isol} | R.M.S. isolation voltage from all three terminals to external heatsink | $f = 50\text{-}60\text{ Hz}$; sinusoidal waveform; $R.H. \leq 65\%$; clean and dustfree | - | - | 2500 | V |
| C_{isol} | Capacitance from T2 to external heatsink | $f = 1\text{ MHz}$ | - | 10 | - | pF |

THERMAL RESISTANCES

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------------------|---|---|------|------|------|------|
| $R_{th\ j\text{-}hs}$ | Thermal resistance junction to heatsink | full or half cycle with heatsink compound | - | - | 4.0 | K/W |
| $R_{th\ j\text{-}a}$ | Thermal resistance junction to ambient | without heatsink compound in free air | - | 55 | 5.5 | K/W |

STATIC CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise stated

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | | | UNIT |
|----------|-----------------------------------|--|------|------|------|------|------|
| | | | | ...D | ...E | ...F | |
| I_{GT} | Gate trigger current ² | BTA212X- | | | | | |
| | | $V_D = 12\text{ V}$; $I_T = 0.1\text{ A}$ T2+ G+ | - | 5 | 10 | 25 | mA |
| | | T2+ G- | - | 5 | 10 | 25 | mA |
| I_L | Latching current | $V_D = 12\text{ V}$; $I_{GT} = 0.1\text{ A}$ T2- G- | - | 5 | 10 | 25 | mA |
| | | T2+ G+ | - | 15 | 25 | 30 | mA |
| | | T2+ G- | - | 25 | 30 | 40 | mA |
| I_H | Holding current | T2- G- | - | 25 | 30 | 40 | mA |
| | | $V_D = 12\text{ V}$; $I_{GT} = 0.1\text{ A}$ | - | 15 | 25 | 30 | mA |
| V_T | On-state voltage | $I_T = 17\text{ A}$ | - | 1.6 | | | V |
| V_{GT} | Gate trigger voltage | $V_D = 12\text{ V}$; $I_T = 0.1\text{ A}$ | - | 1.5 | | | V |
| | | $V_D = 400\text{ V}$; $I_T = 0.1\text{ A}$; $T_j = 125\text{ °C}$ | 0.25 | - | | | V |
| I_D | Off-state leakage current | $V_D = V_{DRM(max)}$; $T_j = 125\text{ °C}$ | - | 0.5 | | | mA |

² Device does not trigger in the T2-, G+ quadrant.

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DYNAMIC CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise stated

| SYMBOL | PARAMETER | CONDITIONS | MIN. | | | MAX. | UNIT |
|---------------|--|---|------|------|------|------|------------|
| | | | ...D | ...E | ...F | | |
| dV_D/dt | Critical rate of rise of off-state voltage | BTA212X- $V_{DM} = 67\% V_{DRM(max)}$; $T_j = 110\text{ °C}$; exponential waveform; gate open circuit | 30 | 60 | 70 | - | V/ μ s |
| di_{com}/dt | Critical rate of change of commutating current | $V_{DM} = 400\text{ V}$; $T_j = 125\text{ °C}$; $I_{T(RMS)} = 12\text{ A}$; $dV_{com}/dt = 20\text{ v}/\mu\text{s}$; gate open circuit | 1.2 | 3.5 | 4.5 | - | A/ms |
| di_{com}/dt | Critical rate of change of commutating current | $V_{DM} = 400\text{ V}$; $T_j = 125\text{ °C}$; $I_{T(RMS)} = 12\text{ A}$; $dV_{com}/dt = 0.1\text{ v}/\mu\text{s}$; gate open circuit | 4.3 | 16 | 19 | - | A/ms |

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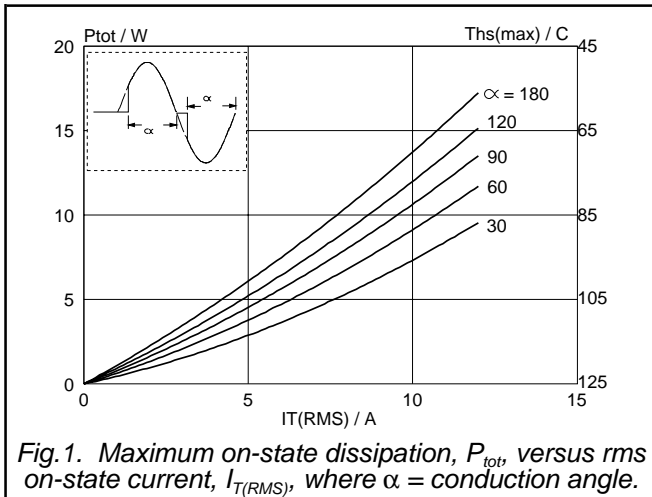


Fig. 1. Maximum on-state dissipation, P_{tot} , versus rms on-state current, $I_{T(RMS)}$, where α = conduction angle.

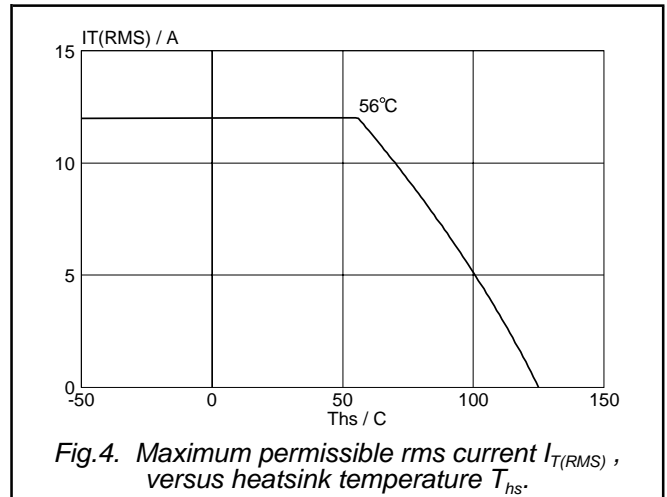


Fig. 4. Maximum permissible rms current $I_{T(RMS)}$, versus heatsink temperature T_{hs} .

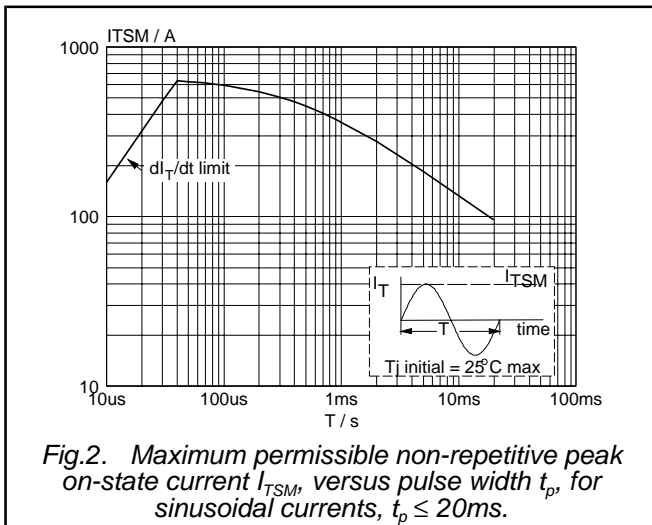


Fig. 2. Maximum permissible non-repetitive peak on-state current I_{TSM} , versus pulse width t_p , for sinusoidal currents, $t_p \leq 20ms$.

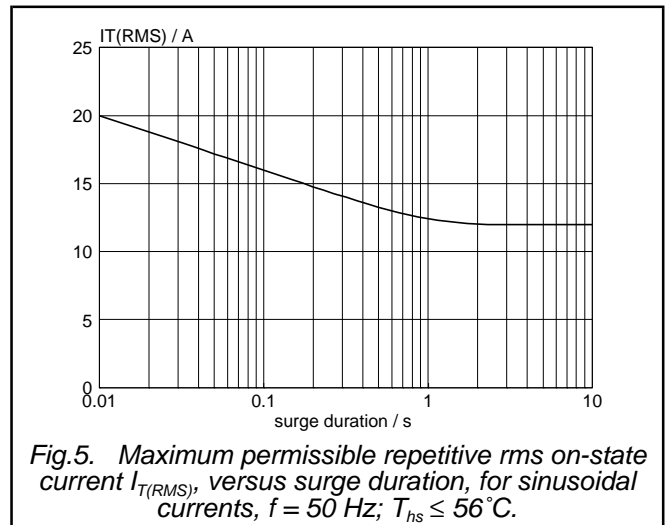


Fig. 5. Maximum permissible repetitive rms on-state current $I_{T(RMS)}$, versus surge duration, for sinusoidal currents, $f = 50 Hz$; $T_{hs} \leq 56^\circ C$.

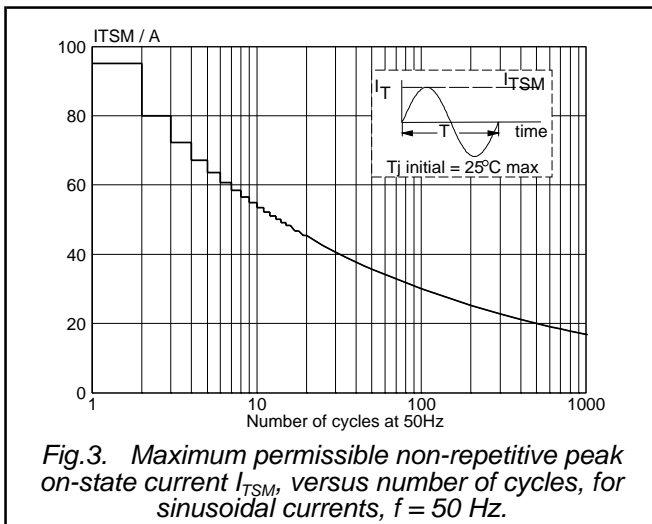


Fig. 3. Maximum permissible non-repetitive peak on-state current I_{TSM} , versus number of cycles, for sinusoidal currents, $f = 50 Hz$.

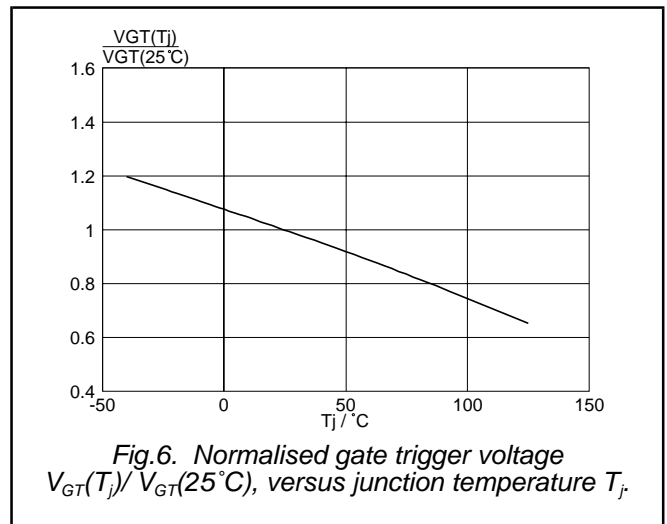
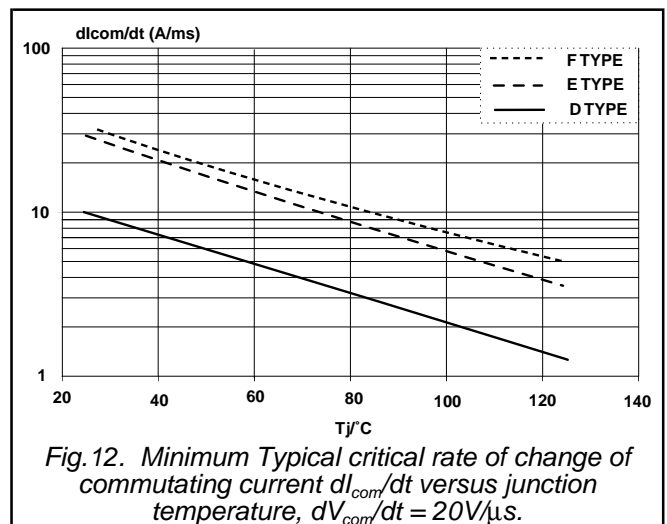
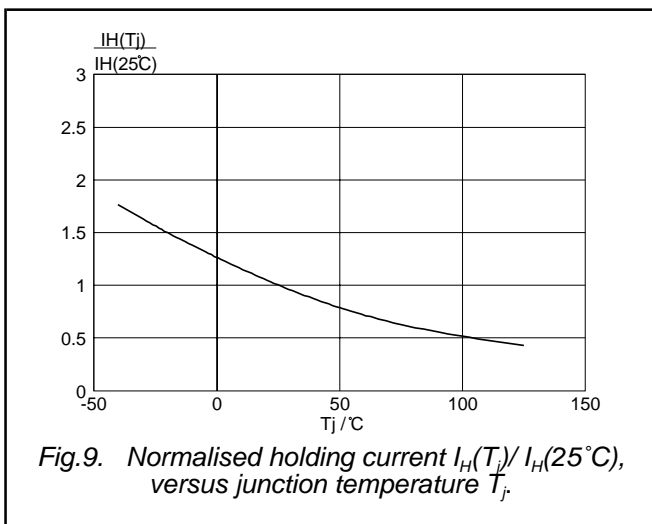
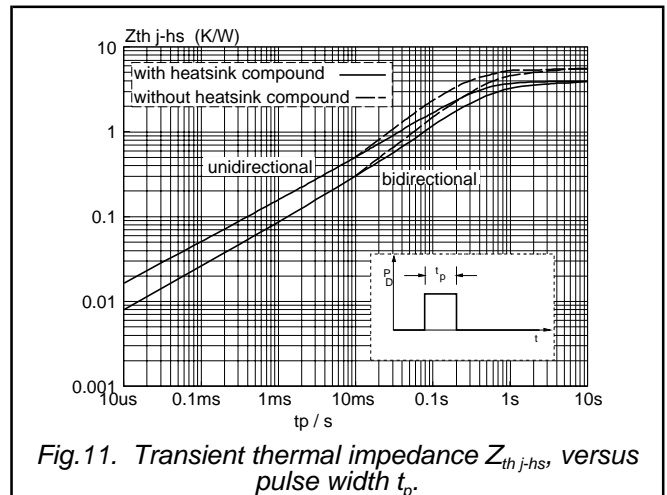
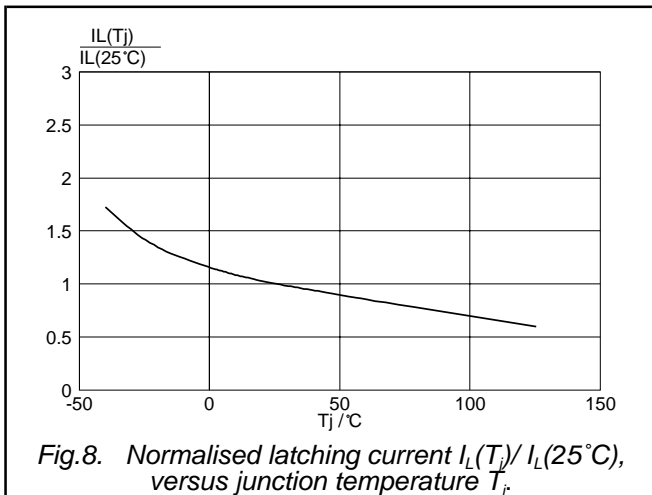
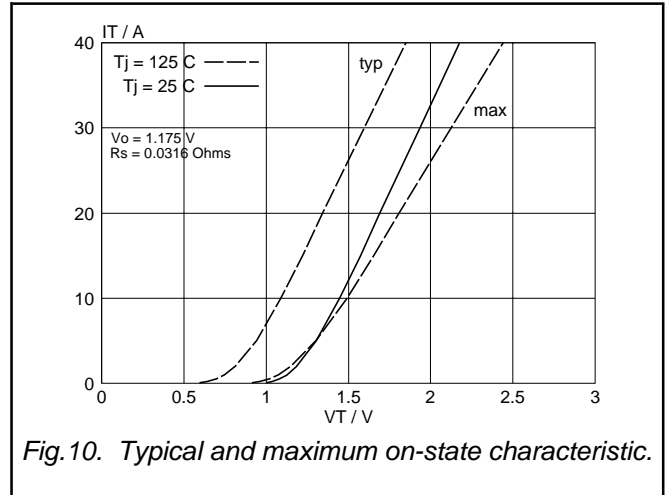
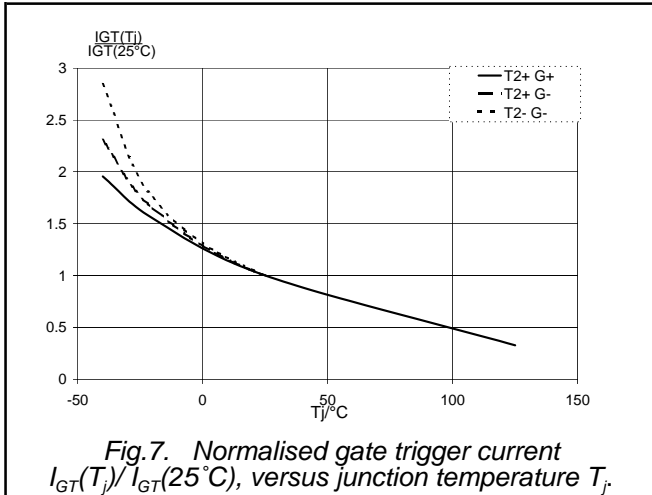


Fig. 6. Normalised gate trigger voltage $V_{GT}(T_j) / V_{GT}(25^\circ C)$, versus junction temperature T_j .

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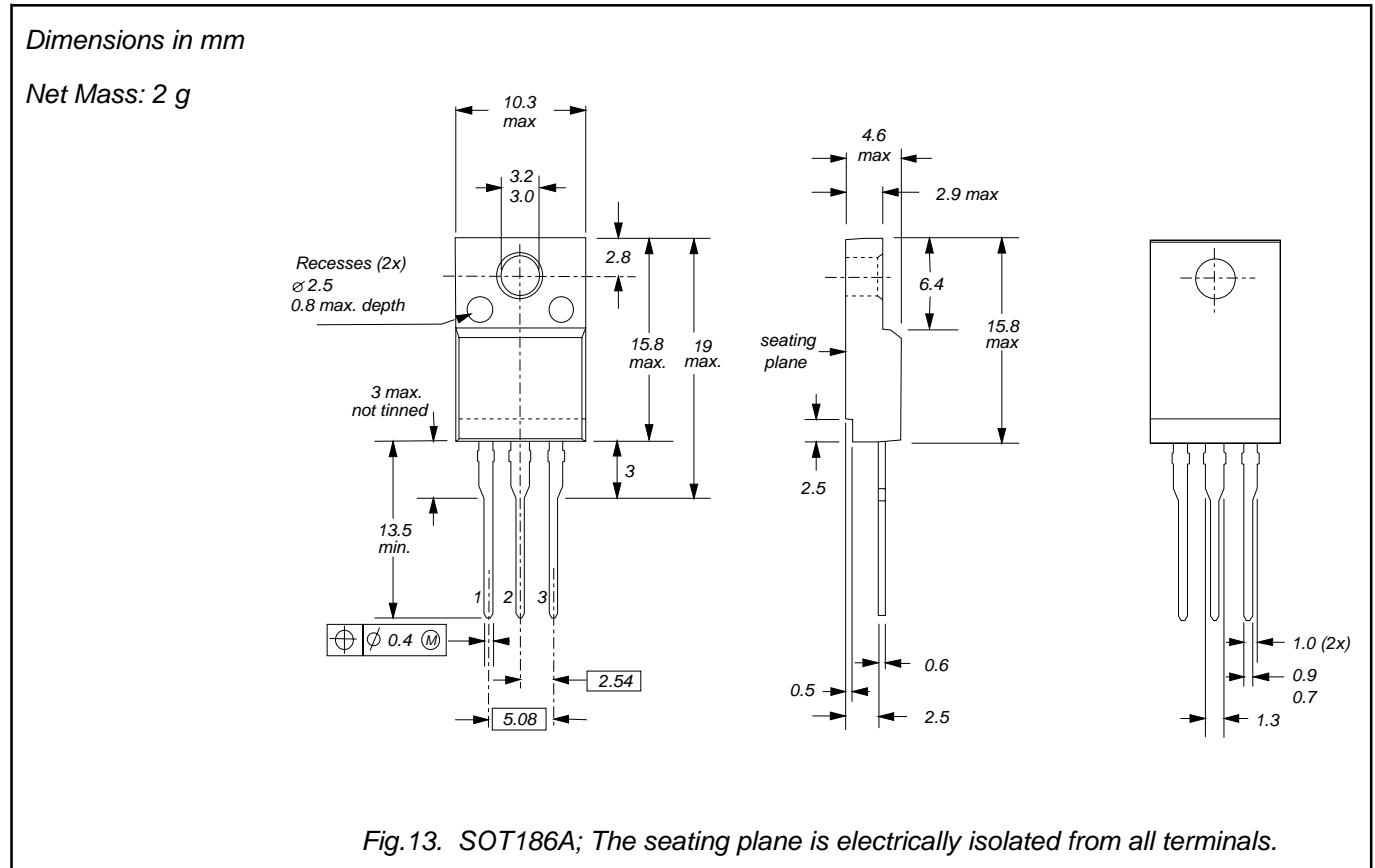
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MECHANICAL DATA



Notes

1. Refer to mounting instructions for F-pack envelopes.
2. Epoxy meets UL94 V0 at 1/8".

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DEFINITIONS

| DATA SHEET STATUS | | |
|--|-----------------------------|---|
| DATA SHEET STATUS ³ | PRODUCT STATUS ⁴ | DEFINITIONS |
| Objective data | Development | This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice |
| Preliminary data | Qualification | This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product |
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| Limiting values | | |
| Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability. | | |
| Application information | | |
| Where application information is given, it is advisory and does not form part of the specification. | | |
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